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Details

Product Status	Active
Core Processor	ARM® Cortex®-M0
Core Size	32-Bit Single-Core
Speed	32MHz
Connectivity	I ² C, LINbus, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, I ² S, POR, PWM, WDT
Number of I/O	26
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	16K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 5.5V
Data Converters	A/D 16x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	38-TFSOP (0.173", 4.40mm Width)
Supplier Device Package	PG-TSSOP-38-9
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/xmc1301t038f0016abxuma1

XMC1300 Data Sheet

Revision History: V1.9 2017-03

Previous Version: V1.8 2016-09

Page	Subjects
Page 10 , Page 12	Add marking option for XMC1301-T038X0032.

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Summary of Features

Table 4 XMC1300 Chip Identification Number (cont'd)

Derivative	Value	Marking
XMC1302-T038X0128	00013013 01FF00FF 00001FF7 0000900F 00000C00 00001000 00021000 201ED083 _H	AB
XMC1302-T038X0200	00013013 01FF00FF 00001FF7 0000900F 00000C00 00001000 00033000 201ED083 _H	AB
XMC1301-Q024F0008	00013062 01CF00FF 00001FF7 0000100F 00000C00 00001000 00003000 201ED083 _H	AB
XMC1301-Q024F0016	00013062 01CF00FF 00001FF7 0000100F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1302-Q024F0016	00013062 01FF00FF 00001FF7 0000900F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1302-Q024F0032	00013062 01FF00FF 00001FF7 0000900F 00000C00 00001000 00009000 201ED083 _H	AB
XMC1302-Q024F0064	00013062 01FF00FF 00001FF7 0000900F 00000C00 00001000 00011000 201ED083 _H	AB
XMC1302-Q024X0016	00013063 01FF00FF 00001FF7 0000900F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1302-Q024X0032	00013063 01FF00FF 00001FF7 0000900F 00000C00 00001000 00009000 201ED083 _H	AB
XMC1302-Q024X0064	00013063 01FF00FF 00001FF7 0000900F 00000C00 00001000 00011000 201ED083 _H	AB
XMC1301-Q040F0008	00013042 01CF00FF 00001FF7 0000100F 00000C00 00001000 00003000 201ED083 _H	AB
XMC1301-Q040F0016	00013042 01CF00FF 00001FF7 0000100F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1301-Q040F0032	00013042 01CF00FF 00001FF7 0000100F 00000C00 00001000 00009000 201ED083 _H	AB
XMC1302-Q040X0016	00013043 01FF00FF 00001FF7 0000900F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1302-Q040X0032	00013043 01FF00FF 00001FF7 0000900F 00000C00 00001000 00009000 201ED083 _H	AB
XMC1302-Q040X0064	00013043 01FF00FF 00001FF7 0000900F 00000C00 00001000 00011000 201ED083 _H	AB

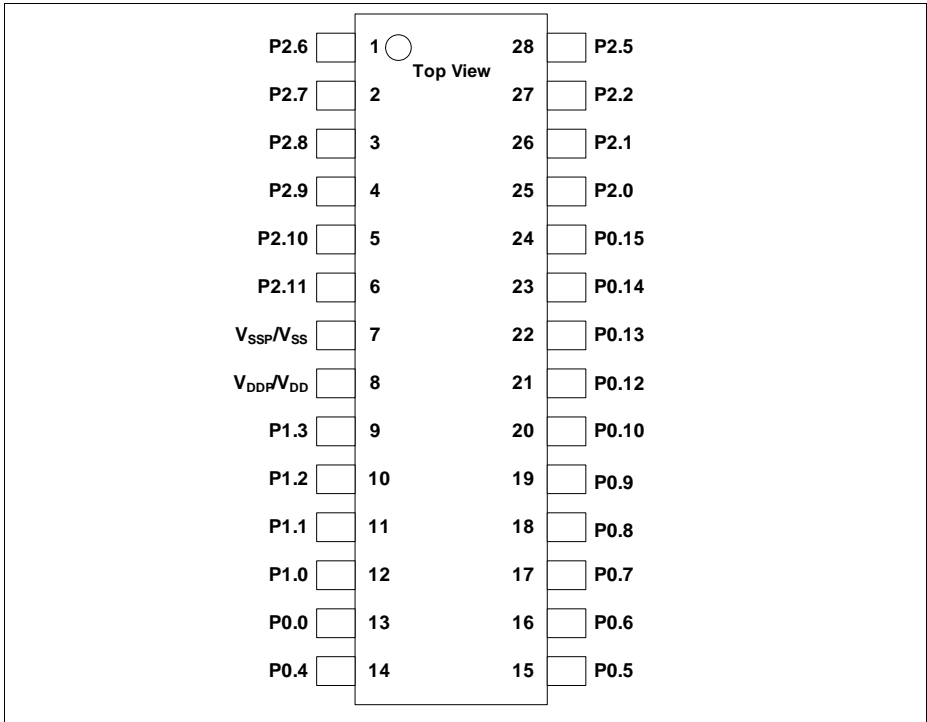


Figure 5 XMC1300 PG-TSSOP-28 Pin Configuration (top view)

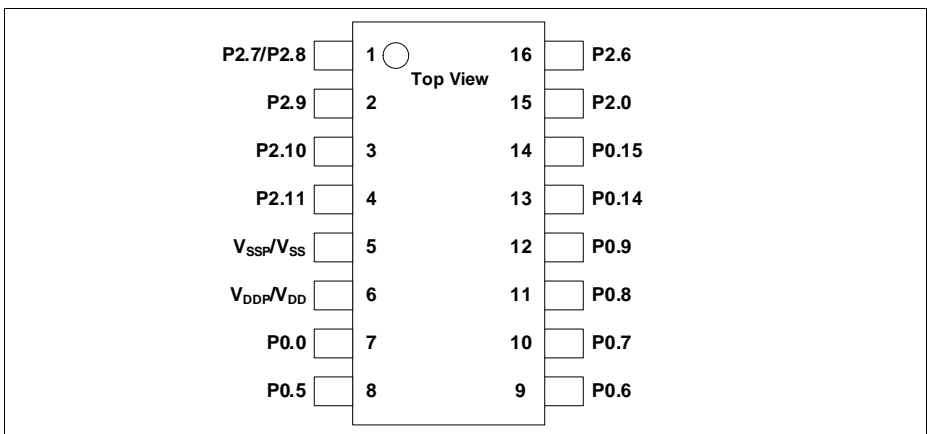


Figure 6 XMC1300 PG-TSSOP-16 Pin Configuration (top view)

General Device Information
Table 6 Package Pin Mapping (cont'd)

Function	VQFN 40	TSSOP 38	TSSOP 28	VQFN 24	TSSOP 16	Pad Type	Notes
P0.7	30	24	17	18	10	STD_IN OUT	
P0.8	33	27	18	19	11	STD_IN OUT	
P0.9	34	28	19	20	12	STD_IN OUT	
P0.10	35	29	20	-	-	STD_IN OUT	
P0.11	36	30	-	-	-	STD_IN OUT	
P0.12	37	31	21	21	-	STD_IN OUT	
P0.13	38	32	22	22	-	STD_IN OUT	
P0.14	39	33	23	23	13	STD_IN OUT	
P0.15	40	34	24	24	14	STD_IN OUT	
P1.0	22	16	12	14	-	High Current	
P1.1	21	15	11	13	-	High Current	
P1.2	20	14	10	12	-	High Current	
P1.3	19	13	9	11	-	High Current	
P1.4	18	12	-	-	-	High Current	
P1.5	17	11	-	-	-	High Current	
P1.6	16	-	-	-	-	STD_IN OUT	
P2.0	1	35	25	1	15	STD_IN OUT/AN	

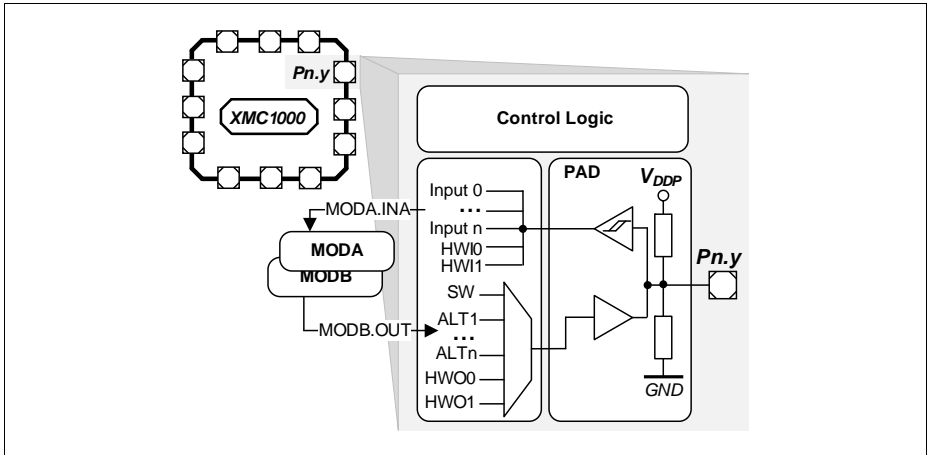


Figure 9 Simplified Port Structure

Pn.y is the port pin name, defining the control and data bits/registers associated with it. As GPIO, the port is under software control. Its input value is read via Pn_IN.y, Pn_OUT defines the output value.

Up to seven alternate output functions (ALT1/2/3/4/5/6/7) can be mapped to a single port pin, selected by Pn_IOCR.PC. The output value is directly driven by the respective module, with the pin characteristics controlled by the port registers (within the limits of the connected pad).

The port pin input can be connected to multiple peripherals. Most peripherals have an input multiplexer to select between different possible input sources.

The input path is also active while the pin is configured as output. This allows to feedback an output to on-chip resources without wasting an additional external pin.

Please refer to the [Port I/O Functions](#) table for the complete Port I/O function mapping.

2.2.3 Hardware Controlled I/O Function Description

The following general building block is used to describe the hardware I/O and pull control functions of each PORT pin:

Table 8 Hardware Controlled I/O Function Description

Function	Outputs	Inputs	Pull Control	
	HWO0	HWI0	HW0_PD	HW0_PU
P0.0	MODB.OUT	MODB.INA		
Pn.y			MODC.OUT	MODC.OUT

By Pn_HWSEL, it is possible to select between different hardware “masters” (HWO0/HWI0, HWO1/HWI1). The selected peripheral can take control of the pin(s). Hardware control overrules settings in the respective port pin registers. Additional hardware signals HW0_PD/HW1_PD and HW0_PU/HW1_PU controlled by the peripherals can be used to control the pull devices of the pin.

Please refer to the [Hardware Controlled I/O Functions](#) table for the complete hardware I/O and pull control function mapping.

3.1.2 Absolute Maximum Ratings

Stresses above the values listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions may affect device reliability.

Table 11 Absolute Maximum Rating Parameters

Parameter	Symbol		Values			Unit	Note / Test Condition
			Min	Typ.	Max.		
Junction temperature	T_J	SR	-40	–	115	°C	–
Storage temperature	T_{ST}	SR	-40	–	125	°C	–
Voltage on power supply pin with respect to V_{SSP}	V_{DDP}	SR	-0.3	–	6	V	–
Voltage on digital pins with respect to V_{SSP} ¹⁾	V_{IN}	SR	-0.5	–	$V_{DDP} + 0.5$ or max. 6	V	whichever is lower
Voltage on P2 pins with respect to V_{SSP} ²⁾	V_{INP2}	SR	-0.3	–	$V_{DDP} + 0.3$	V	–
Voltage on analog input pins with respect to V_{SSP}	V_{AIN} V_{AREF}	SR	-0.5	–	$V_{DDP} + 0.5$ or max. 6	V	whichever is lower
Input current on any pin during overload condition	I_{IN}	SR	-10	–	10	mA	–
Absolute maximum sum of all input currents during overload condition	ΣI_{IN}	SR	-50	–	+50	mA	–

1) Excluding port pins P2.[1,2,6,7,8,9,11].

2) Applicable to port pins P2.[1,2,6,7,8,9,11].

3.2 DC Parameters

3.2.1 Input/Output Characteristics

Table 16 provides the characteristics of the input/output pins of the XMC1300.

Note: These parameters are not subject to production test, but verified by design and/or characterization.

Note: Unless otherwise stated, input DC and AC characteristics, including peripheral timings, assume that the input pads operate with the standard hysteresis.

Table 16 Input/Output Characteristics (Operating Conditions apply)

Parameter	Symbol	Limit Values		Unit	Test Conditions
		Min.	Max.		
Output low voltage on port pins (with standard pads)	V_{OLP} CC	-	1.0	V	$I_{OL} = 11 \text{ mA}$ (5 V) $I_{OL} = 7 \text{ mA}$ (3.3 V)
		-	0.4	V	$I_{OL} = 5 \text{ mA}$ (5 V) $I_{OL} = 3.5 \text{ mA}$ (3.3 V)
Output low voltage on high current pads	V_{OLP1} CC	-	1.0	V	$I_{OL} = 50 \text{ mA}$ (5 V) $I_{OL} = 25 \text{ mA}$ (3.3 V)
		-	0.32	V	$I_{OL} = 10 \text{ mA}$ (5 V)
		-	0.4	V	$I_{OL} = 5 \text{ mA}$ (3.3 V)
Output high voltage on port pins (with standard pads)	V_{OHP} CC	$V_{DDP} - 1.0$	-	V	$I_{OH} = -10 \text{ mA}$ (5 V) $I_{OH} = -7 \text{ mA}$ (3.3 V)
		$V_{DDP} - 0.4$	-	V	$I_{OH} = -4.5 \text{ mA}$ (5 V) $I_{OH} = -2.5 \text{ mA}$ (3.3 V)
Output high voltage on high current pads	V_{OHP1} CC	$V_{DDP} - 0.32$	-	V	$I_{OH} = -6 \text{ mA}$ (5 V)
		$V_{DDP} - 1.0$	-	V	$I_{OH} = -8 \text{ mA}$ (3.3 V)
		$V_{DDP} - 0.4$	-	V	$I_{OH} = -4 \text{ mA}$ (3.3 V)
Input low voltage on port pins (Standard Hysteresis)	V_{ILPS} SR	-	$0.19 \times V_{DDP}$	V	CMOS Mode (5 V, 3.3 V & 2.2 V)

Electrical Parameters

Table 16 Input/Output Characteristics (Operating Conditions apply) (cont'd)

Parameter	Symbol		Limit Values		Unit	Test Conditions
			Min.	Max.		
Input high voltage on port pins (Standard Hysteresis)	V_{IHPS}	SR	$0.7 \times V_{DDP}$	–	V	CMOS Mode (5 V, 3.3 V & 2.2 V)
Input low voltage on port pins (Large Hysteresis)	V_{ILPL}	SR	–	$0.08 \times V_{DDP}$	V	CMOS Mode (5 V, 3.3 V & 2.2 V) ¹⁸⁾
Input high voltage on port pins (Large Hysteresis)	V_{IHPL}	SR	$0.85 \times V_{DDP}$	–	V	CMOS Mode (5 V, 3.3 V & 2.2 V) ¹⁸⁾
Rise time on High Current Pad ¹⁾	t_{HCPR}	CC	–	9	ns	50 pF @ 5 V ²⁾
			–	12	ns	50 pF @ 3.3 V ³⁾
			–	25	ns	50 pF @ 1.8 V ⁴⁾
Fall time on High Current Pad ¹⁾	t_{HCPF}	CC	–	9	ns	50 pF @ 5 V ²⁾
			–	12	ns	50 pF @ 3.3 V ³⁾
			–	25	ns	50 pF @ 1.8 V ⁴⁾
Rise time on Standard Pad ¹⁾	t_R	CC	–	12	ns	50 pF @ 5 V ⁵⁾
			–	15	ns	50 pF @ 3.3 V ⁶⁾
			–	31	ns	50 pF @ 1.8 V ⁷⁾
Fall time on Standard Pad ¹⁾	t_F	CC	–	12	ns	50 pF @ 5 V ⁵⁾
			–	15	ns	50 pF @ 3.3 V ⁶⁾
			–	31	ns	50 pF @ 1.8 V ⁷⁾

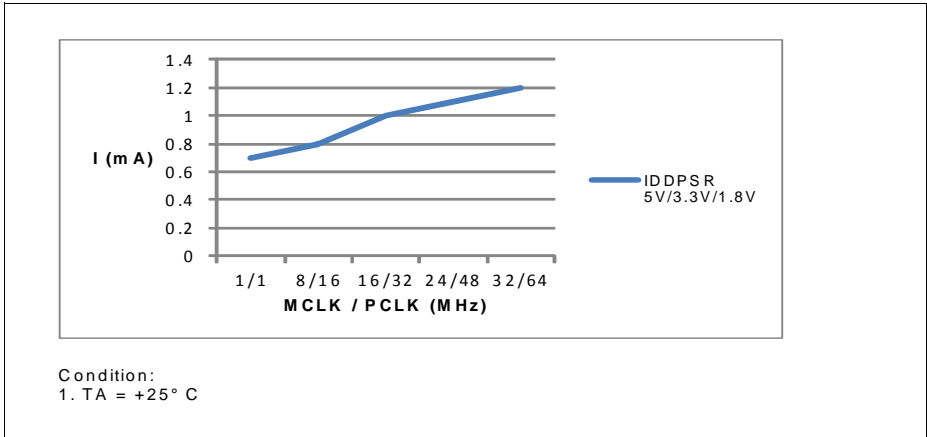
Electrical Parameters
Table 16 Input/Output Characteristics (Operating Conditions apply) (cont'd)

Parameter	Symbol	Limit Values	Unit	Test Conditions	
					Min.
Input Hysteresis ⁸⁾	HYS CC	0.08 × V _{DDP}	–	V	CMOS Mode (5 V), Standard Hysteresis
		0.03 × V _{DDP}	–	V	CMOS Mode (3.3 V), Standard Hysteresis
		0.02 × V _{DDP}	–	V	CMOS Mode (2.2 V), Standard Hysteresis
		0.5 × V _{DDP}	0.75 × V _{DDP}	V	CMOS Mode(5 V), Large Hysteresis
		0.4 × V _{DDP}	0.75 × V _{DDP}	V	CMOS Mode(3.3 V), Large Hysteresis
		0.2 × V _{DDP}	0.65 × V _{DDP}	V	CMOS Mode(2.2 V), Large Hysteresis
Pin capacitance (digital inputs/outputs)	C _{IO} CC	–	10	pF	
Pull-up resistor on port pins	R _{PUP} CC	20	50	kohm	V _{IN} = V _{SSP}
Pull-down resistor on port pins	R _{PDP} CC	20	50	kohm	V _{IN} = V _{DDP}
Input leakage current ⁹⁾	I _{OZP} CC	-1	1	μA	0 < V _{IN} < V _{DDP} , T _A ≤ 105 °C
Voltage on any pin during V _{DDP} power off	V _{PO} SR	–	0.3	V	¹⁰⁾
Maximum current per pin (excluding P1, V _{DDP} and V _{SS})	I _{MP} SR	-10	11	mA	–
Maximum current per high current pins	I _{MP1A} SR	-10	50	mA	–
Maximum current into V _{DDP} (TSSOP16, VQFN24)	I _{MVDD1} SR	–	130	mA	¹⁸⁾
Maximum current into V _{DDP} (TSSOP38, VQFN40)	I _{MVDD2} SR	–	260	mA	¹⁸⁾

Electrical Parameters
Table 17 ADC Characteristics (Operating Conditions apply)¹⁾ (cont'd)

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gain settings	G_{IN} CC	1			–	GNCTRxz.GAINy = 00 _B (unity gain)
		3			–	GNCTRxz.GAINy = 01 _B (gain g1)
		6			–	GNCTRxz.GAINy = 10 _B (gain g2)
		12			–	GNCTRxz.GAINy = 11 _B (gain g3)
Sample Time	t_{sample} CC	3	–	–	1 / f_{ADC}	$V_{DD} = 5.0$ V
		3	–	–	1 / f_{ADC}	$V_{DD} = 3.3$ V
		30	–	–	1 / f_{ADC}	$V_{DD} = 2.0$ V
Sigma delta loop hold time	t_{SD_hold} CC	20	–	–	µs	Residual charge stored in an active sigma delta loop remains available
Conversion time in fast compare mode	t_{CF} CC	9			1 / f_{ADC}	²⁾
Conversion time in 12-bit mode	t_{C12} CC	20			1 / f_{ADC}	²⁾
Maximum sample rate in 12-bit mode ³⁾	f_{C12} CC	–	–	$f_{ADC} / 42.5$	–	1 sample pending
		–	–	$f_{ADC} / 62.5$	–	2 samples pending
Conversion time in 10-bit mode	t_{C10} CC	18			1 / f_{ADC}	²⁾
Maximum sample rate in 10-bit mode ³⁾	f_{C10} CC	–	–	$f_{ADC} / 40.5$	–	1 sample pending
		–	–	$f_{ADC} / 58.5$	–	2 samples pending
Conversion time in 8-bit mode	t_{C8} CC	16			1 / f_{ADC}	²⁾

Figure 15 shows typical graphs for sleep mode current for $V_{DDP} = 5V$, $V_{DDP} = 3.3V$, $V_{DDP} = 1.8V$ across different clock frequencies.



**Figure 15 Sleep mode, peripherals clocks disabled, Flash powered down:
Supply current I_{DDPSR} over supply voltage V_{DDP} for different clock frequencies**

3.3.3 On-Chip Oscillator Characteristics

Note: These parameters are not subject to production test, but verified by design and/or characterization.

Table 25 provides the characteristics of the 64 MHz clock output from the digital controlled oscillator, DCO1 in XMC1300.

Table 25 64 MHz DCO1 Characteristics (Operating Conditions apply)

Parameter	Symbol		Limit Values			Unit	Test Conditions
			Min.	Typ.	Max.		
Nominal frequency	f_{NOM}	CC	–	64	–	MHz	under nominal conditions ¹⁾ after trimming
Accuracy ²⁾	Δf_{LT}	CC	-1.7	–	3.4	%	with respect to $f_{\text{NOM}}(\text{typ})$, over temperature ($T_A = 0\text{ °C}$ to 85 °C)
			-3.9	–	4.0	%	with respect to $f_{\text{NOM}}(\text{typ})$, over temperature ($T_A = -40\text{ °C}$ to 105 °C)

1) The deviation is relative to the factory trimmed frequency at nominal V_{DDC} and $T_A = +25\text{ °C}$.

2) The accuracy can be further improved through alternative methods, refer to XMC1000 Oscillator Handling Application Note.

3.3.5 SPD Timing Requirements

The optimum SPD decision time between 0_B and 1_B is $0.75 \mu\text{s}$. With this value the system has maximum robustness against frequency deviations of the sampling clock on tool and on device side. However it is not always possible to exactly match this value with the given constraints for the sample clock. For instance for a oversampling rate of 4, the sample clock will be 8 MHz and in this case the closest possible effective decision time is 5.5 clock cycles ($0.69 \mu\text{s}$).

Table 28 Optimum Number of Sample Clocks for SPD

Sample Freq.	Sampling Factor	Sample Clocks 0_B	Sample Clocks 1_B	Effective Decision Time ¹⁾	Remark
8 MHz	4	1 to 5	6 to 12	$0.69 \mu\text{s}$	The other closest option ($0.81 \mu\text{s}$) for the effective decision time is less robust.

1) Nominal sample frequency period multiplied with $0.5 + (\text{max. number of } 0_B \text{ sample clocks})$

For a balanced distribution of the timing robustness of SPD between tool and device, the timing requirements for the tool are:

- Frequency deviation of the sample clock is +/- 5%
- Effective decision time is between $0.69 \mu\text{s}$ and $0.75 \mu\text{s}$ (calculated with nominal sample frequency)

3.3.6 Peripheral Timings

Note: These parameters are not subject to production test, but verified by design and/or characterization.

3.3.6.1 Synchronous Serial Interface (USIC SSC) Timing

The following parameters are applicable for a USIC channel operated in SSC mode.

Note: Operating Conditions apply.

Table 29 USIC SSC Master Mode Timing

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
SCLKOUT master clock period	t_{CLK} CC	62.5	–	–	ns	
Slave select output SELO active to first SCLKOUT transmit edge	t_1 CC	80	–	–	ns	
Slave select output SELO inactive after last SCLKOUT receive edge	t_2 CC	0	–	–	ns	
Data output DOUT[3:0] valid time	t_3 CC	-10	–	10	ns	
Receive data input DX0/DX[5:3] setup time to SCLKOUT receive edge	t_4 SR	80	–	–	ns	
Data input DX0/DX[5:3] hold time from SCLKOUT receive edge	t_5 SR	0	–	–	ns	

Table 30 USIC SSC Slave Mode Timing

Parameter	Symbol		Values			Unit	Note / Test Condition
			Min.	Typ.	Max.		
DX1 slave clock period	t_{CLK}	SR	125	–	–	ns	
Select input DX2 setup to first clock input DX1 transmit edge ¹⁾	t_{10}	SR	10	–	–	ns	
Select input DX2 hold after last clock input DX1 receive edge ¹⁾	t_{11}	SR	10	–	–	ns	
Receive data input DX0/DX[5:3] setup time to shift clock receive edge ¹⁾	t_{12}	SR	10	–	–	ns	
Data input DX0/DX[5:3] hold time from clock input DX1 receive edge ¹⁾	t_{13}	SR	10	–	–	ns	
Data output DOUT[3:0] valid time	t_{14}	CC	-	–	80	ns	

1) These input timings are valid for asynchronous input signal handling of slave select input, shift clock input, and receive data input (bits DXnCR.DSEN = 0).

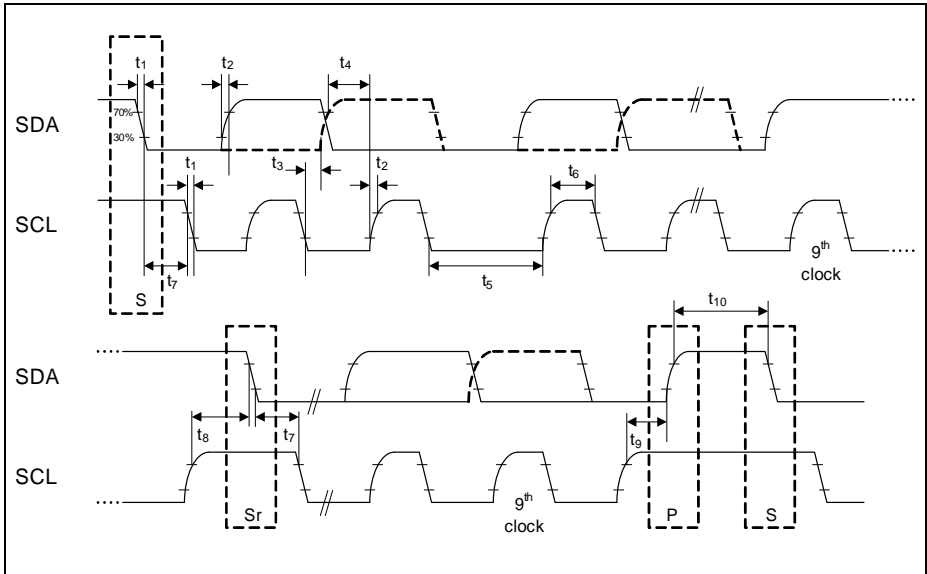


Figure 23 USIC IIC Stand and Fast Mode Timing

3.3.6.3 Inter-IC Sound (IIS) Interface Timing

The following parameters are applicable for a USIC channel operated in IIS mode.

Note: Operating Conditions apply.

Table 33 USIC IIS Master Transmitter Timing

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Clock period	t_1 CC	$2/f_{MCLK}$	-	-	ns	$V_{DDP} \geq 3\text{ V}$
		$4/f_{MCLK}$	-	-	ns	$V_{DDP} < 3\text{ V}$
Clock HIGH	t_2 CC	$0.35 \times t_{1min}$	-	-	ns	
Clock Low	t_3 CC	$0.35 \times t_{1min}$	-	-	ns	
Hold time	t_4 CC	0	-	-	ns	
Clock rise time	t_5 CC	-	-	$0.15 \times t_{1min}$	ns	

5 Quality Declaration

Table 36 shows the characteristics of the quality parameters in the XMC1300.

Table 36 Quality Parameters

Parameter	Symbol	Limit Values		Unit	Notes
		Min.	Max.		
ESD susceptibility according to Human Body Model (HBM)	V_{HBM} SR	-	2000	V	Conforming to EIA/JESD22-A114-B
ESD susceptibility according to Charged Device Model (CDM) pins	V_{CDM} SR	-	500	V	Conforming to JESD22-C101-C
Moisture sensitivity level	MSL CC	-	3	-	JEDEC J-STD-020D
Soldering temperature	T_{SDR} SR	-	260	°C	Profile according to JEDEC J-STD-020D